

Notice of References Cited

Application/Control No.

10/500,511

Applicant(s)/Patent Under
Reexamination
BADYLAK ET AL.

Examiner

Shin-Lin Chen

Art Unit

1632

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,734,018	05-2004	Wolfenbarger et al.	435/378
*	B	US-6,866,686	03-2005	Ollerenshaw et al.	623/23.72
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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